Analytical Reference Materials International



Certificate of Analysis Certified Reference Material

Grade: **CDA 482 / UNS C48200**Part Number (Q.A. NO.): **IARM 75C**

Interpretation of Data

- 1. Certified values listed below reflect analysis results submitted by qualified analytical laboratories using a combination of methods and instrumentation that emulate actual methods and instrumental techniques currently utilized in the analytical community and are reported as % wt. unless otherwise noted.
- 2. Any data reported and enclosed by a **parentheses** () is a "best estimate" and is **NOT CERTIFIED**. This data could not be quantified sufficiently for certification. It was however, reported by enough laboratories to be considered as potentially present in the matrix of the material being examined.
- 3. The "Inter laboratory Analysis Program" (ILAP) utilized in the establishment of the data are an ongoing program with permanent membership. Certain elements may be selected by a consensus of the members for more extensive testing. Therefore the data in **brackets** [] **indicates further testing is in process.**Chips are not certified for Oxygen analysis.
- 4. The "**±Estimated Uncertainty**" is enclosed by a **parentheses** () **below** the individual **element's concentration** and is based on a Confidence Interval at 95%. Included in this estimated uncertainty, are the combined effects of method imprecision, material inhomogeneity, and any bias between methods.

Important: A "User Registration Card" accompanies all shipments. This card should be completed immediately upon receipt of materials with the appropriate user information. This is the only way in which ARMI can guarantee customer updates or possible data modifications!

Aluminum	Antimony	Arsenic	Beryllium	Bismuth	Boron	Cadmium	Carbon	Chromium
(0.003)	0.007	0.005	(<0.001)	0.0012	(<0.1)	0.0015	(0.002)	0.0009
	(0.005)	(0.002)		(0.0007)		(0.0009)		(0.0003)
Cobalt	Copper	<u>Iron</u>	Lead	Magnesium	Manganese	<u>Nickel</u>	<u>Niobium</u>	Nitrogen
0.0007	60.7	0.06	0.42	(0.0003)	0.0024	0.013	(<0.001)	(0.0006)
(0.0004)	(0.2)	(0.01)	(0.02)		(0.0009)	(0.003)		
<u>Oxygen</u>	Phosphorus	Selenium	Silicon	<u>Silver</u>	<u>Sulfur</u>	<u>Tellurium</u>	<u>Tin</u>	Zinc
(0.0007)	0.004	(0.005)	0.005	(0.004)	0.0015	(0.003)	0.69	38.1
	(0.001)		(0.003)		(0.0006)		(0.01)	(0.4)

Zirconium

(<0.001)

The laboratories participating in the "Inter-Laboratory Analysis Program" (ILAP) and certification of this material are as follows:

Anderson Laboratories, Inc. - Greendale, WI Atlas Pacific Corporation - Colton, CA

Colonial Metals Co. - Columbia, PA

Concast Metal Products Co. - Mars, PA

Element - Newtown, PA

Exova - Gary, IN

I. Schumann & Company - Bedford, OH

Laboratory Testing, Inc. - Hatfield, PA

NSL Analytical Services - Cleveland, OH

Sipi-Metals Corp - Chicago, IL

Special Metals IncoTest - Hereford, UK

Traceability: All members of the "Inter-Laboratory Analysis Program" (ILAP) listed above validate test methods and instrument performance utilizing SRMs produced by the National Institute of Standards and Technology, (NIST) as well as other CRMs and RMs produced by recognized Certifying Bodies from around the world. The specific SRMs, CRMs, and RMs applicable to the material covered by this certificate are:

ALPHA AR881	BNF C38/01-1	BS 482A	CTIF LH12	IARM 75A	LECO 501-147	NIST 3105A	NIST 3149
ALPHA AR892	BNF C38/02-1	CTIF L1A	CTIF LH13A	IARM 75B	LECO 501-550	NIST 3106	NIST 3150
ALPHA AR946	BNF C38/03-1	CTIF L2	CTIF LH2	IH 857	LECO 501-643	NIST 3112A	NIST 37D
BCS 179/2	BNF C38/04-1	CTIF L20A	CTIF LH5A	IMN WM1	LECO 502-102	NIST 3113	NIST 37E
BCS 351	BNF C38/05-1	CTIF L3A	CTIF LH6-1	IMN WM2	MBH 31X7835.6A	NIST 3132	NIST 898
BCS 390	BNF C42/21-1	CTIF L4-1	CTIF LH6A	IMN WM3	MBH 31XB26C	NIST 3136	NIST3102A
BCS 454/1	BNF C42/22-1	CTIF L6A	CTIF LH7-1A	IMN WM4	NIST 3101A	NIST 3137	RC 11/2
BCS 462/1	BNF C42/23	CTIF LH1	IARM 73B	IMN WM5	NIST 3103A	NIST 3139A	WILLAN NB4E

A specific line of traceability is established to NIST and other Certifying Bodies for those elements that are noted as "Certified Values" on the Certificates of Analyses referenced above.

See Reverse Side for Statistical Data and Additional Information Regarding this Material.

The following data and accompanying statements represent all pertinent information reported in the ILAP as it applies to the chemical characterization of this material as of 10/11/2017.

75C	Al	Sb	As	Be	Bi	В	Cd	С	Cr	Co	Cu	Fe	Pb	Mg	Mn	Ni
1	0.0007	0.0025	0.0028	0.0001	0.0003	0.001	0.0005	0.0005	0.0005	0.0001	60.04	0.018	0.369	0.0001	0.0012	0.001
2	0.0010	0.0028	0.0035	0.0001	0.0004	0.067	0.0010	0.0007	0.0007	0.0002	60.45	0.0192	0.378	0.0004	0.0017	0.0074
3	0.002	0.005	0.0038	0.0012	0.0009	< 0.0001	0.0011	0.0023	0.0010	0.0006	60.52	0.0546	0.391	0.0005	0.0020	0.0092
4	0.0027	0.005	0.0042	< 0.0001	0.0009	< 0.001	0.0012	0.0034	0.0010	0.0009	60.58	0.056	0.410	< 0.0001	0.002	0.01
5	0.005	0.0065	0.0061	< 0.0001	0.0010		0.0013	0.0038	0.0010	0.0010	60.676	0.0604	0.411		0.002	0.012
6	0.0083	0.0131	0.0068	< 0.0001	0.0013		0.002	< 0.005	0.0014	0.0010	60.75	0.0638	0.4216		0.002	0.0140
7	< 0.0001	0.0159	0.007	< 0.0010	0.0025		0.0036			0.001	60.81	0.0640	0.43		0.0024	0.014
8	< 0.0001		0.009		0.0026						60.84	0.065	0.4336		0.0035	0.0144
9	< 0.0001										60.9	0.066	0.4373		0.005	0.0144
10											61.2528	0.066	0.4416			0.015
11												0.0671	0.4450			0.0157
12												0.0694	0.46			0.0174
13												0.07				0.024
14																
15																
Mean	0.003	0.007	0.005	0.000	0.0012	0.03	0.0015	0.002	0.0009	0.0007	60.7	0.06	0.42	0.0003	0.0024	0.013
STDV.	0.003	0.005	0.002	0.001	0.0009	0.05	0.0010	0.002	0.0003	0.0004	0.3	0.02	0.03	0.0002	0.0011	0.005
Certified	(0.003)	0.007	0.005	(<0.001)	0.0012	(<0.1)	0.0015	(0.002)	0.0009	0.0007	60.7	0.06	0.42	(0.0003)	0.0024	0.013
95% C.I.		0.005	0.002		0.0007		0.0009		0.0003	0.0004	0.2	0.01	0.02		0.0009	0.003
Methods	O,IM,I	O,IM,I	O,IM,I	O,IM,I	O,IM,I	O,IM,I	O,IM,I	С	O,IM,I	O,IM,I	W,O	O,IM,I	X,W,O,I	O,IM,I	O,IM,I	O,IM,I

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES

75C	Nb	N	0	Р	Se	Si	Ag	S	Te	Sn	Zn	Zr		
1	0.001	0.0001	0.00023	0.001	0.0001	0.0022	0.002	0.0001	0.0003	0.660	37.00	< 0.0001		
2	< 0.0001	0.0004	0.00034	0.002	0.0003	0.0023	0.0037	0.0002	0.0006	0.6699	37.4637	< 0.0001		
3	< 0.0001	0.00091	0.0004	0.0028	0.003	0.0026	0.004	0.0008	0.0038	0.67	37.94	< 0.001		
4	< 0.0001	0.00092	0.0009	0.0030	0.0162	0.003	0.0048	0.0016	0.0048	0.68	37.978			
5	< 0.0010	< 0.001	0.0015	0.0033	< 0.00003	0.0031	0.0065	0.0018	0.0061	0.68	38.12			
6			< 0.001	0.0034	< 0.0001	0.0090		0.0020		0.6804	38.15			
7				0.0035	< 0.0010	0.009		0.0020		0.688	38.233			
8				0.0036		0.00946		0.002		0.700	38.31			
9				0.0052				0.002		0.70	38.34			
10				0.0053				0.0022		0.706	38.426			
11				0.0055						0.7233	39.178			
12				0.006						0.725				
13														
14														
15														
Mean	0.001	0.0006	0.0007	0.004	0.005	0.005	0.004	0.0015	0.003	0.69	38.1			
STDV.		0.0004	0.0005	0.002	0.008	0.003	0.002	0.0008	0.003	0.02	0.6			
Certified	(<0.001)	(0.0006)	(0.0007)	0.004	(0.005)	0.005	(0.004)	0.0015	(0.003)	0.69	38.1	(<0.001)		
95% C.I.				0.001		0.003		0.0006		0.01	0.4			
Methods	O,IM,I	F	F	X,O,IM,I	O,IM,I,A	O,I M,I	O,IM,I	O,I,C	O,IM,I	X,W,O,I	O,I	IM,I		

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES

The International Standards Organization (ISO) definitions, expressed in ISO Guide 30-1992 list the following:

Certifying Body: Any technically competent body (organization or firm, public or private) that issues a reference material certificate, which provides the information, detailed in ISO Guide 31. The only generally accepted certifying body in the United States for primary standards - Standard Reference Materials (SRM) is the U. S. Department of Commerce, National Institute of Standards & Technology, (NIST), Gaithersburg, MD. All other certifying bodies in the United States produce Reference Materials (RM) or Certified Reference Materials (CRM).

Reference Material (RM): Material or substance one or more of whose property values are sufficiently homogeneous and well established to be used for the calibration of an apparatus, the assessment of a measurement method, or for assigning values to materials.

Certified Reference Material (CRM): Reference material, accompanied by a certificate, one or more of whose property values are certified by a procedure, which establishes its traceability to an accurate realization of the unit in which the property values are expressed, and for which each certified value is accompanied by an uncertainty at a stated level of confidence.

Inter-Laboratory Analysis Program (ILAP): Although ASTM Standard E691-87 applies to inter-laboratory studies to "Determine the Precision of a Single Test Method", it is also a well thought out and logical plan for conducting an inter laboratory program involving multiple techniques. Therefore, the planning, conducting, analyzing, protocol, and treatment of data resulting from this inter laboratory program were performed utilizing the guidelines established in ASTM E691-87.

Methods of Analysis: In view of the fact, that the "Inter Laboratory Analysis Program" entails a wide variety of materials, no single analytical method would provide optimum data results. Therefore, the methods utilized were a combination of ASTM Standard Methods for classical wet chemistry, ICP, AA, Optical Emission, and X-Ray spectrometric methods. The determinations for Carbon, Sulfur, Nitrogen, and Oxygen are the result of combustion and OE instrument procedures.

Expiration of Certification: The certification of this IARM is valid indefinitely, within the uncertainty specified, provided the IARM is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the IARM is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

Instructions for Use: The test surface is the side opposite to the labeled surface, which includes the IARM number. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing as these processes may contaminate the surface. When not in use, the material should be stored in a cool, dry location. This material was tested using both the solid disks and chips prepared from the disks. The certified values are considered representative of the overall average composition of the material. Chips are not to be used for Oxygen analysis.

Selection of Materials: A "batch" or "series" is defined as a single bar of one continuous length and heat. The majority of materials are in wrought condition; other methods of manufacture are utilized as a less desirable resort. ILAP samples are taken by removing a section, a minimum of, every one-twelfth of total length from the entire bar. A portion of the section is converted to chips and thin (pin) disk for analysis by classical wet chemistry, ICP, AA, and combustion procedures, and the balance remains as a thick disk for OES and X-Ray analysis. This systematic sampling procedure results in the homogeneity being reflected as a product of the overall statistics and certified data. This method of homogeneity testing is in accordance with ISO Guide 34, regarding the systematic selection and testing of a representative number of units for the assessment of homogeneity.

David Coler, General Manager

Analytical Reference Materials International

ISO 9001:2008

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